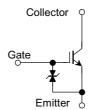
Preliminary

TOSHIBA Insulated Gate Bipolar Transistor Silicon N Channel MOS Type

GT5G102

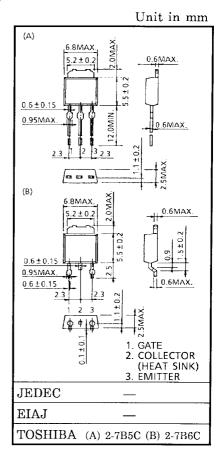
Strobe Flash Applications

- 3rd Generation
- High input impedance
- Low saturation voltage
 - V_{CE} (sat) = 8 V (max) (I_{C} = 130 A)
- Enhancement-mode
- 12 V gate drive



Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit	
Collector-emitter voltage		V _{CES}	400	V	
Gate-emitter voltage	DC	V_{GES}	±20	V	
Collector current	DC	Ic	5	Α	
	1 ms	I _{CP}	130	Α	
Collector power dissipation	Ta = 25°C	PC	1.3	W	
	Tc = 25°C	P _C	20	W	
Junction temperature		Tj	150	°C	
Storage temperature range		T _{stg}	-55~150	°C	



Weight: 0.36 g

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Electrical Characteristics (Ta = 25°C)

Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current		I _{GES}	V _{GE} = 20 V, V _{CE} = 0	_	_	10	μΑ
Collector cut-off current		I _{CES}	V _{CE} = 400 V, V _{GE} = 0	_	_	10	μА
Gate-emitter cut-off voltage		V _{GE} (OFF)	$I_C = 1 \text{ mA}, V_{CE} = 5 \text{ V}$	2	_	5	V
Collector-emitter saturation voltage		V _{CE (sat)}	I _C = 130 A, V _{GE} = 12 V (pulsed)	_	5	8	V
Input capacitance		C _{ies}	V _{CE} = 10 V, V _{GE} = 0, f = 1 MHz	_	1200	_	pF
Switching time	Rise time	t _r	$\begin{array}{cccccccccccccccccccccccccccccccccccc$		0.7	_	μs
	Turn-on time	t _{on}		_	0.9	_	
	Fall time	t _f		_	1.7	_	
	Turn-off time	t _{off}		_	2.0	_	
Thermal resistance		R _{th (j-c)}	_	_	_	6.25	°C/W

This transistor is an electrostatic sensitive device. Please handle with caution.